

[54] MICROMETER

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[52] U.S. Cl. .... D10/73

[58] Field of Search ..... D10/73; 33/143 F, 143 G, 33/147 J, 147 T, 147 R, 166 R

[56]

References Cited

U.S. PATENT DOCUMENTS

D. 163,776	6/1951	Semeneck .....	D10/73
1,561,630	11/1925	Wilson .....	33/147 G
1,945,796	2/1934	Ames .....	33/147 F
2,378,093	6/1945	Monies .....	33/147 G
2,599,971	6/1952	Brown .....	33/147 G
2,927,376	3/1960	Oettl .....	33/147 F
3,196,546	7/1965	Himmelsbach .....	33/166 X
4,355,468	10/1982	Mizuno .....	33/147 F

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[57]

CLAIM

The ornamental design for a micrometer, as shown.

DESCRIPTION

FIG. 1 is a front and top-left perspective view of a micrometer showing our new design;  
FIG. 2 is a top plan view thereof;  
FIG. 3 is a bottom plan view thereof;  
FIG. 4 is a front elevational view thereof;  
FIG. 5 is a rear elevational view thereof;  
FIG. 6 is a left side elevational view thereof;  
FIG. 7 is a right side elevational view thereof.

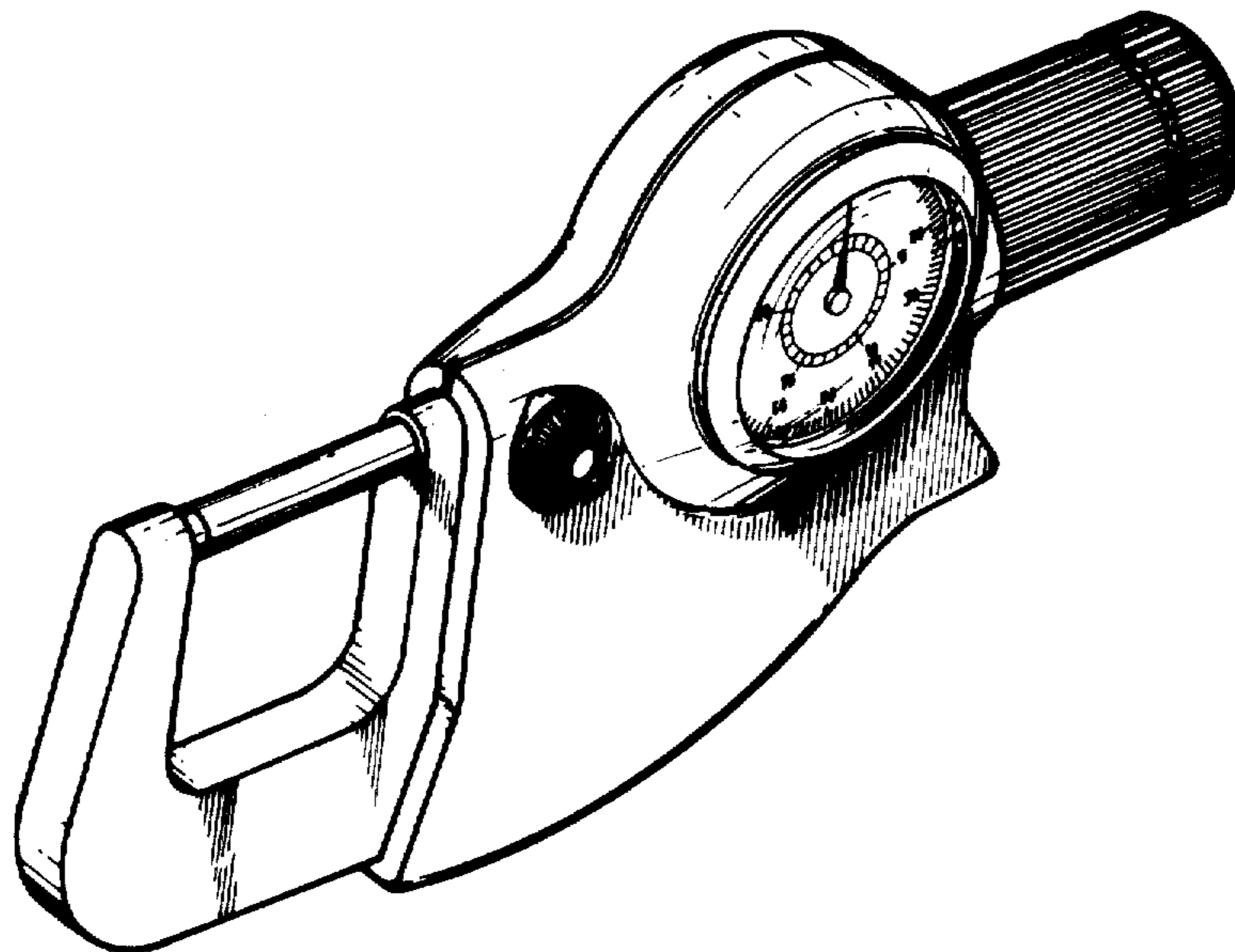


FIG. 1

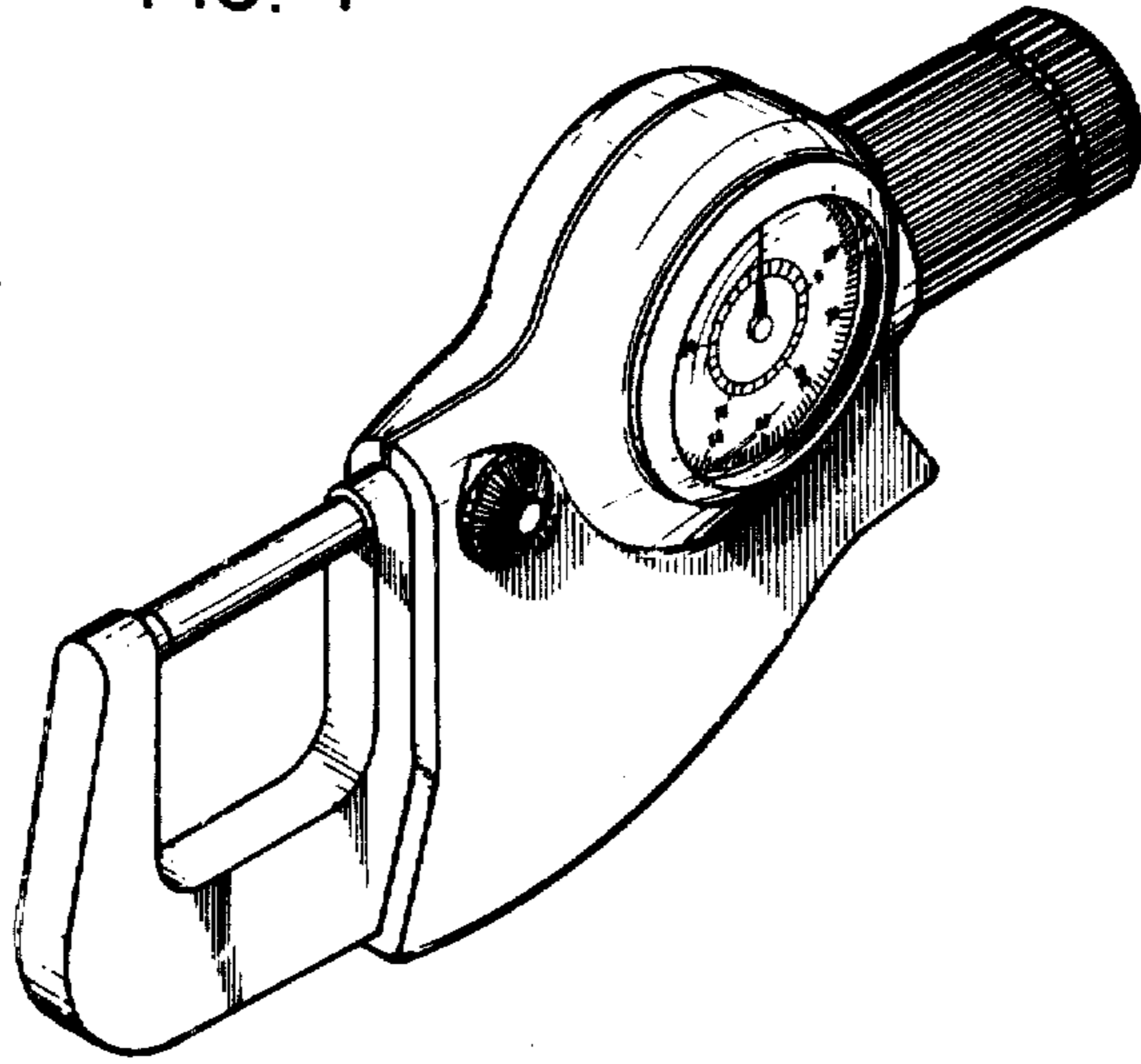


FIG. 2

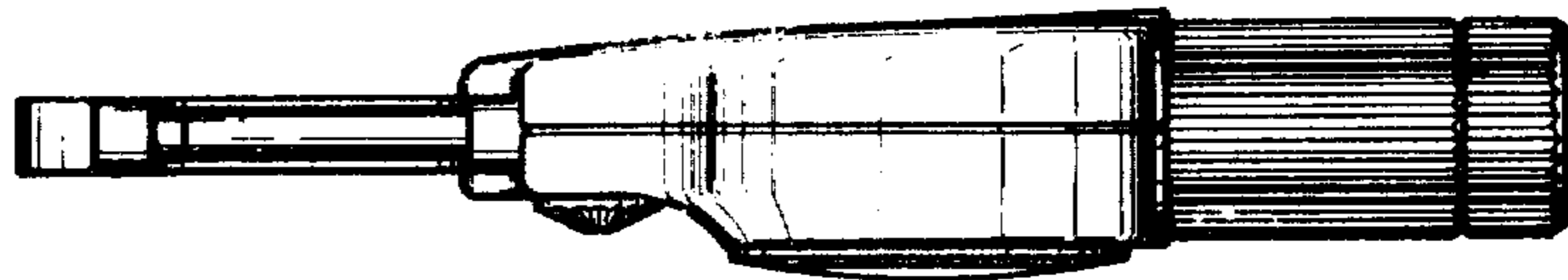


FIG. 3



FIG. 4

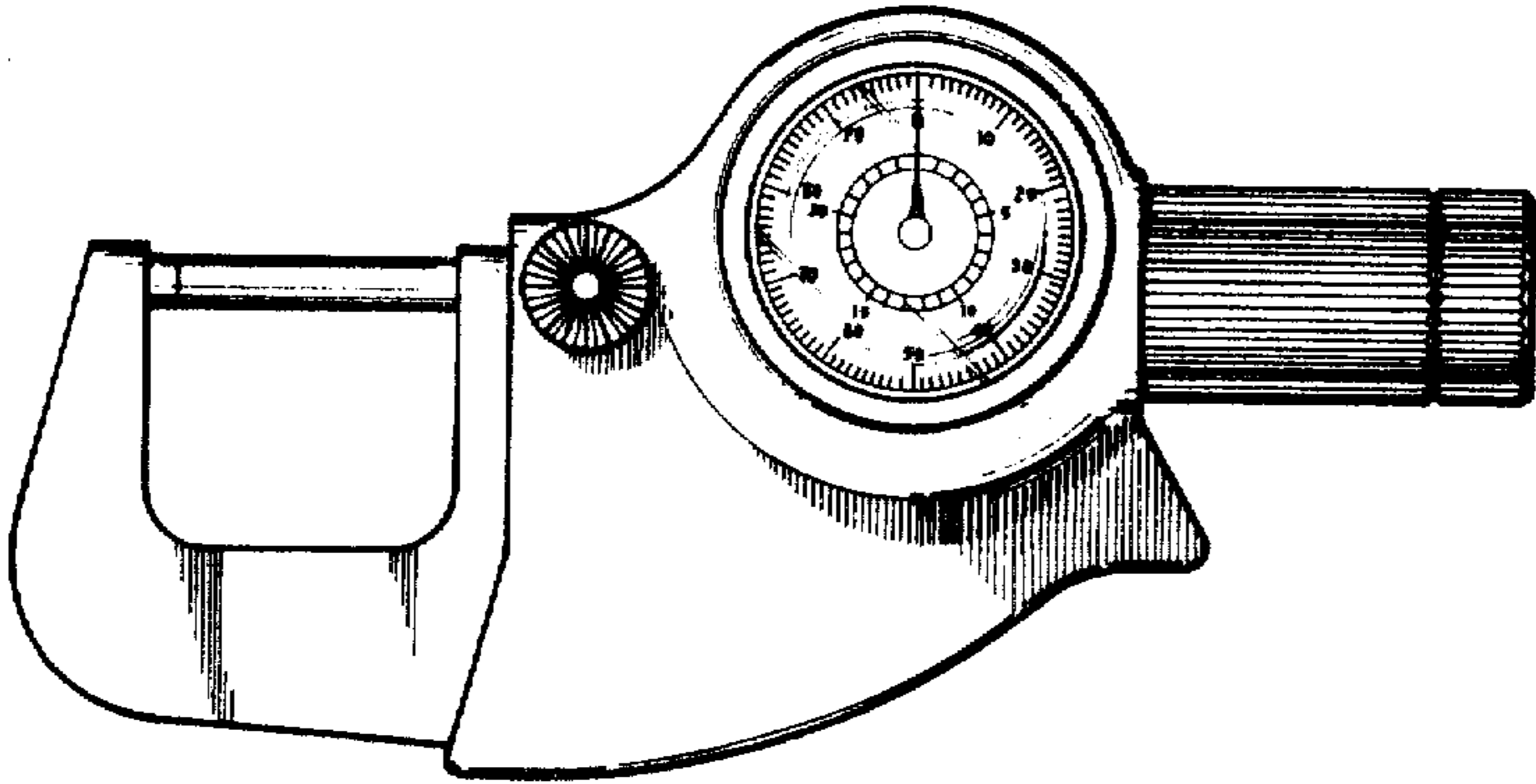


FIG. 5

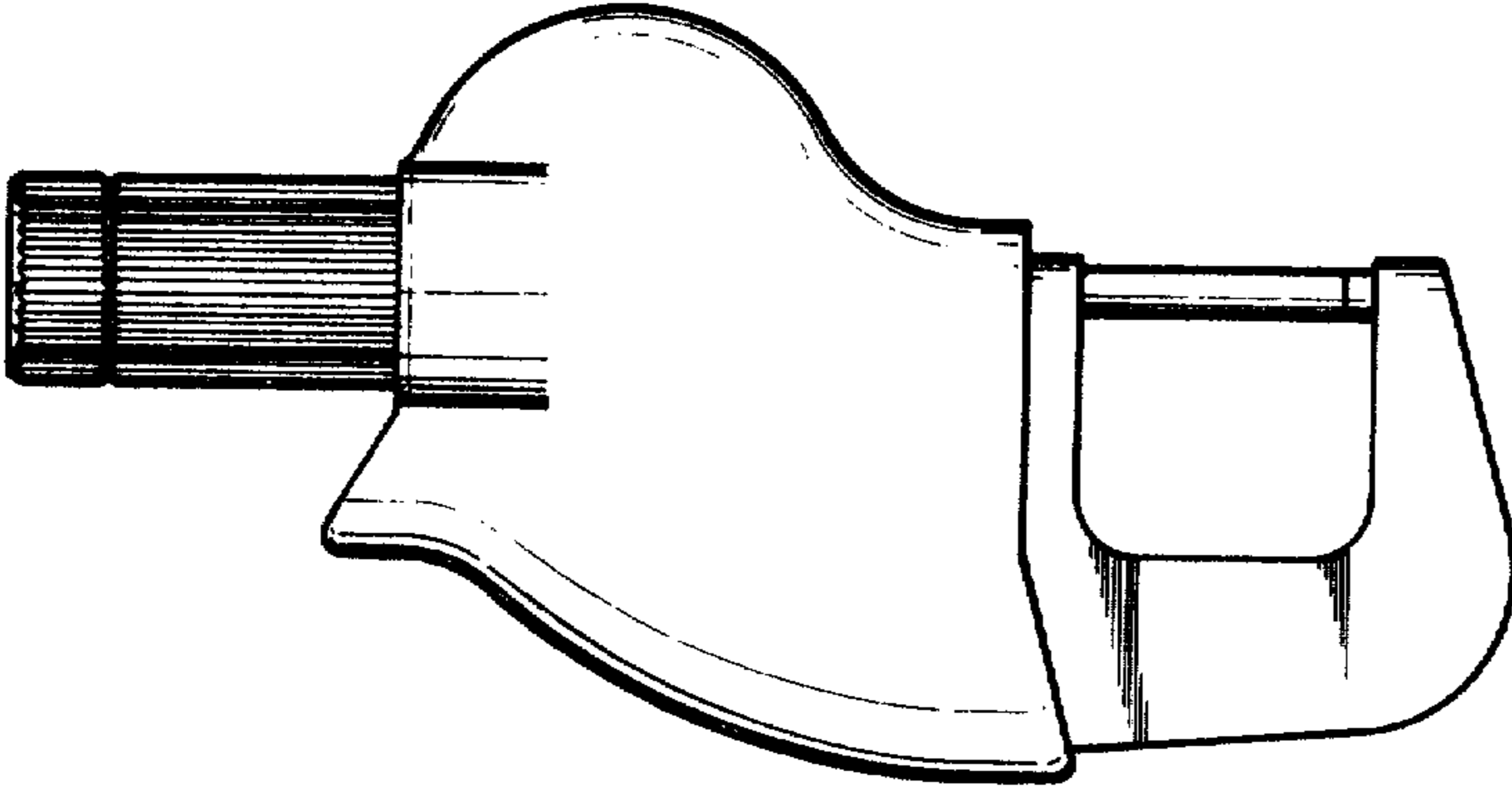


FIG. 6

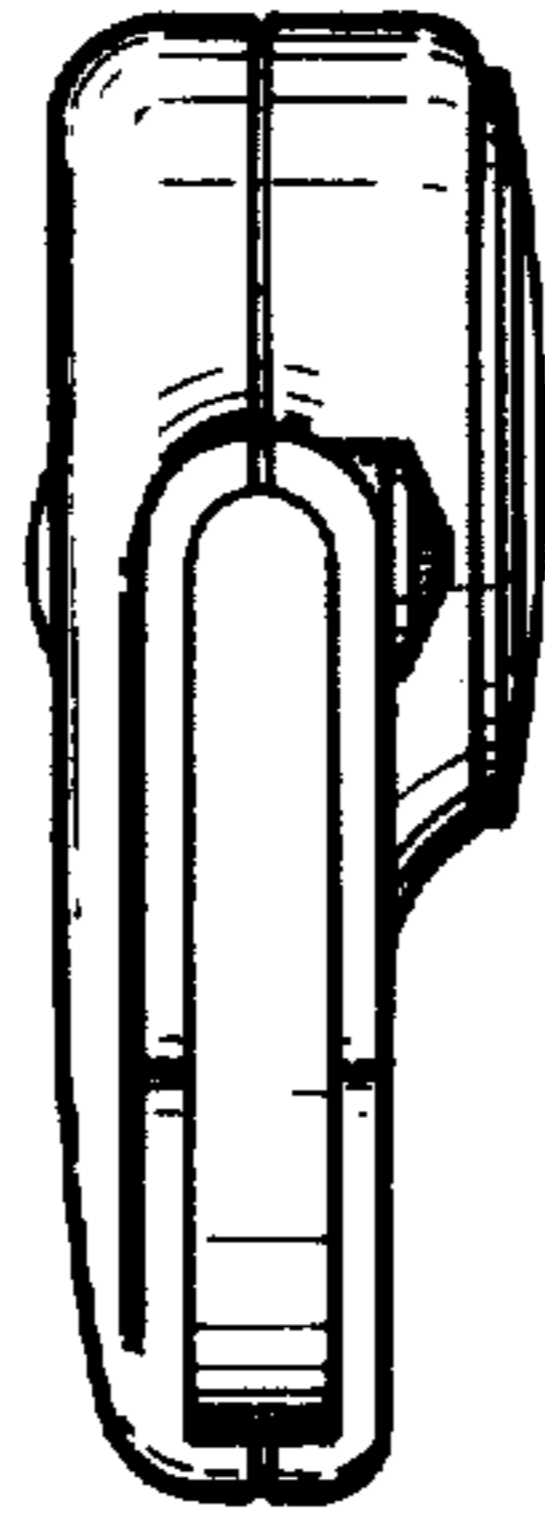


FIG. 7

